

**International Journal of Current
Microbiology and Applied Sciences
(IJCMAS) NAAS RATING-5.38, ICV-95.39**
ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

**An International, Monthly, Online, Free Access, Peer Reviewed,
Indexed, fast track Scientific Research Journal**

Certificate of Publication

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2020.9.(3):1103-1108

<https://doi.org/10.20546/ijcmas.2020.903.129>

Synthetic Hexaploid Wheat 'Synthetic 45': A Novel Source for Leaf Rust Resistance Gene in Wheat

Prem Chand Gyani^{1*}, Pooja Yadav² and J. B. Sharma¹

¹Division of Genetics, ICAR-Indian Agricultural Research Institute, New Delhi 110012, India

²Department of Genetics and Plant Breeding, RVSKVV, Gwalior 474002, India

Dr. M. Prakash
Editor-in-chief

International Journal of Current Microbiology and Applied Sciences

www.ijcmas.com

www.excellentpublishers.com



© International Journal of Current Microbiology and Applied
Sciences (IJCMAS)

www.excellentpublishers.com www.ijcmas.com